Attorney's Docket No.: 2562C2-369003

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant: Andreas N. Wiswesser et al.

Examiner: Robert A. Rose

Filed

Title

Serial No.: 10/616,488

: July 8, 2003

: ENDPOINT DETECTION WITH MULTIPLE LIGHT BEAMS

## MAIL STOP AMENDMENT

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

## INFORMATION DISCLOSURE STATEMENT

Applicants request consideration of the references listed on the attached PTO-1449 form. Under 37 C.F.R. § 1.98 (a)(2)(ii), only copies of foreign patent documents and/or non-patent literature are enclosed. Copies of any listed U.S. patents or U.S. patent application publications can be provided upon request.

This statement is being filed after a first Office action on the merits, but before receipt of a final Office action or a Notice of Allowance. Please charge the fee of \$180 to Deposit Account No. 06-1050, for the late submission fee of §1.17(p). Please apply any other charges or credits to Deposit Account No. 06-1050.

Respectfully submitted,

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## CERTIFICATE OF TRANSMISSION BY FACSIMILE

I hereby certify that this correspondence is being transmitted by facsimile to the Patent and Trademark Office on the date indicated below.

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Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 002562C2-369003	Application No. 10/616,488	
	losure Statement plicant	Applicant Andreas N. Wiswesser et al.		
(Use several sheets if necessary) (37 CFR §1.98(b))		Filing Date July 8, 2003	Group Art Unit 3725	

U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication / Issue Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA	6,146,248	11/14/2000	Jairath et al.			
	AB	6,261,155 B1	07/17/2001	Jairath et al.			
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Foreign Patent Documents or Published Foreign Patent Applications								
Examiner	Desig.	Document	Publication	Country or			Trans	lation
Initial	ID	Number	Date	Patent Office	Class	Subclass	Yes	No
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	AO							
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	Other Documents (include Author, Title, Date, and Place of Publication)					
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Examiner Signature	Date Considered
EXAMINER: Initials citation considered. Draw line through citation if no	t in conformance and not considered. Include copy of this form with
next communication to applicant.	